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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/710,298	CHEN ET AL.	
Examiner	Art Unit	
Don P. Le	2819	

SEARCHED					
Class	Subclass	Date	Examiner		
326	26, 27, 80- 83	6/10/2005	DL		
327	535-537	6/10/2005	DL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
326	81, 83	6/13/2005	DL	
327	535	6/13/2005	DL	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST UPDATED	6/13/2005	DL		
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